

**Search Notes**

Application/Control No.

10/757,192

Examiner

Raymond Phan

Applicant(s)/Patent under  
Reexamination

DEWITT ET AL.

Art Unit

2111

**SEARCHED**

Class	Subclass	Date	Examiner
710	260-269	10/24/2006	RP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
710	260,261	10/27/2006	RP
710	263,269	10/27/2006	RP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR